Application/Control No.	Applicant(s)/Patent un Reexamination	der
10/768,724	LIU ET AL.	
Examiner	Art Unit	
Fric R Chan	1765	

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INT	ERFERENC	E SEARCH	ED
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Inventor search (PALM)	9/30/2005	EC
EAST (all databases) - see search history printout	10/7/2005	EC
216/41,58,67,72,74,75,79,81; 430/314-317; 438/706,710,717,723, 724 (text search only) (consulted L. Vihn AU 1765)	10/7/2005	EC